


<b>Search Notes</b> 	<b>Application/Control No.</b> 10590565	<b>Applicant(s)/Patent Under Reexamination</b> PAREEK ET AL.
	<b>Examiner</b> HENG M CHAN	<b>Art Unit</b> 1795

SEARCHED			
Class	Subclass	Date	Examiner
424	474, 475, 480, 481, 482	11/25/2009	HMC
106	163.01, 172.1, 178.1,	11/25/2009	HMC
UPDATED		5/29/2010	HMC

SEARCH NOTES		
Search Notes	Date	Examiner
EAST: USPAT, US-PGPUB, USOCR, JPO, EPO, FPRS, DERWENT, IBM-TDB	11/24/2009	HMC
Inventors searched in Palm	11/24/2009	HMC
Consulted Jerry Lorenzo about 112 2nd issues	11/24/2009	HMC
Assignee searched in EAST	11/25/2009	HMC
UPDATED	5/28	HMC
Consulted Nikki Dees about areas of search	5/24	HMC
Consulted Jennifer Michener about claim 1	6/1	HMC
Consulted Carlos Barcena about claim 6	6/3	HMC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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